


<b>Search Notes</b>  	<b>Application/Control No.</b>  10689669	<b>Applicant(s)/Patent Under Reexamination</b>  ICHIKAWA ET AL.
	<b>Examiner</b>  Chu, Randolph	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	176	9/25/2006	ric
382	173	9/25/2006	ric
358	453	9/25/2006	ric
358	450	9/25/2006	ric

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	9/26/2006	ric
Inventor Name Search	9/26/2006	ric
Consult with Andy Johns	9/26/2006	ric
Consult with Mark Zimmernan	9/26/2006	ric
Consult with Kimerly Williams	9/26/2006	ric
Consult with Wenpeng Chen	9/26/2006	ric
Updated EAST Search	4/16/2008	ric
Updated EAST Search	10/28/2008	ric

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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